

<b>Notice of References Cited</b>	Application/Control No. 09/544,054	Applicant(s)/Patent Under Reexamination YONA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,625,780 A	04-1997	Hsieh et al.	710/316
*	B	US-6,126,451 A	10-2000	Zandy et al.	439/61
*	C	US-6,751,214 B1	06-2004	Parruck et al.	370/352
*	D	US-6,513,078 B1	01-2003	Kaganoi et al.	710/104
*	E	US-4,933,845	06-1990	Hayes, Dennis F.	710/104
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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